

Vishay Siliconix

N-Channel 190-V (D-S) MOSFET

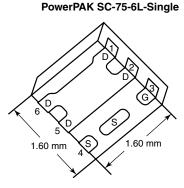
PRODUCT SUMMARY				
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)	
	2.4 at V _{GS} = 4.5 V	1.5		
190	2.6 at V _{GS} = 2.5 V	1.48	2.3 nC	
	6.0 at V _{GS} = 1.8 V	0.4		

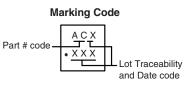
FEATURES

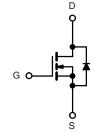
- Halogen-free
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] SC-75 Package
 - Small Footprint Area
 - Low On-Resistance

APPLICATIONS

Boost Converter for Portable Devices







Ordering Information: SiB452DK-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	190	V		
Gate-Source Voltage		V _{GS}	± 16	- v	
	T _C = 25 °C		1.5		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	1.24		
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C	U	0.67 ^{b, c}		
	T _A = 70 °C		0.53 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	1.5	1	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	1.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	'5	0.67 ^{b, c}		
	T _C = 25 °C		13		
Maximum Power Dissipation	T _C = 70 °C	Pn	8.4	w	
	T _A = 25 °C	U	2.4 ^{b, c}	~ ~ ~	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	41	51	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	thJC 7.5 9.5		0/10	

Notes:

a. $T_C = 25 \ ^{\circ}C.$

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 105 °C/W.

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COMPLIANT

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.



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SPECIFICATIONS $T_J = 25 \degree C$			NA:	T	Merr	11	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static		V _{GS} = 0 V, I _D = 250 μA	100				
Drain-Source Breakdown Voltage	V _{DS}	$v_{GS} = 0 v, I_D = 250 \mu A$	190			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I _D = 250 μA		202		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 3.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	0.6		1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 16 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 190 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
		V_{DS} = 190 V, V_{GS} = 0 V, T_{J} = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, $V_{GS} = 4.5$ V	1.5			Α	
		V _{GS} = 4.5 V, I _D = 0.5 A		1.8	2.4		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 0.45 A		1.9	2.6	Ω	
		V _{GS} = 1.8 V, I _D = 0.2 A		2.0	6.0	1	
Forward Transconductance ^a	9 _{fs}	$V_{\rm DS} = 10 \text{ V}, \text{ I}_{\rm D} = 0.5 \text{ A}$		3		S	
Dynamic ^b	013						
Input Capacitance	C _{iss}			135		1	
	C _{oss}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz				pF	
Output Capacitance		$v_{\rm DS} = 30 v, v_{\rm GS} = 0 v, t = 1 witz$		9			
Reverse Transfer Capacitance	C _{rss}			-	0.5	<u> </u>	
Total Gate Charge	Qg	$V_{DS} = 95$ V, $V_{GS} = 10$ V, $I_{D} = 0.7$ A		4.3	6.5	nC	
Cata Source Charge	0			2.3 0.4	3.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 95 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 0.7 \text{ A}$		-			
Gate-Drain Charge	Q _{gd}			1.0		0	
Gate Resistance	R _g	f = 1 MHz		2.2		Ω	
Turn-On Delay Time	t _{d(on)}			12	20	- ns	
Rise Time	t _r	$V_{DD} = 95 \text{ V}, \text{ R}_{L} = 190 \Omega$		16	25		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 0.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		30	45		
Fall Time	t _f			15	25		
Turn-On Delay Time	t _{d(on)}			5	10		
Rise Time	t _r	V_{DD} = 95 V, R_L = 190 Ω		10	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 0.5$ A, V_{GEN} = 10 V, R_g = 1 Ω		10	15		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			1.5	A	
Pulse Diode Forward Current	I _{SM}				1.5		
Body Diode Voltage	V _{SD}	$I_{\rm S}$ = 0.5 A, $V_{\rm GS}$ = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge				45	70	nC	
Reverse Recovery Fall Time		t_a $t_F = 0.5 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, } t_J = 25 \text{ °C}$		20		ns	
Reverse Recovery Rise Time	t _b			19			

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

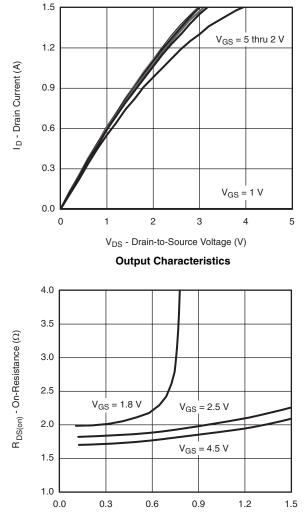
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





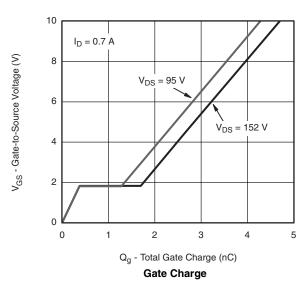
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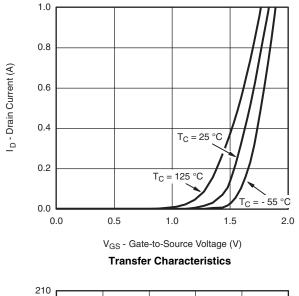


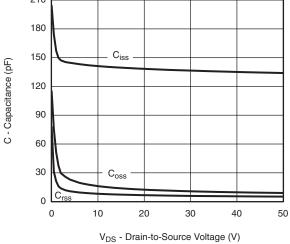


I_D - Drain Current (A)

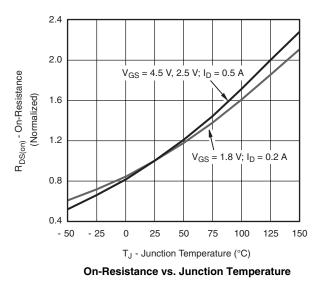
On-Resistance vs. Drain Current and Gate Voltage







Capacitance

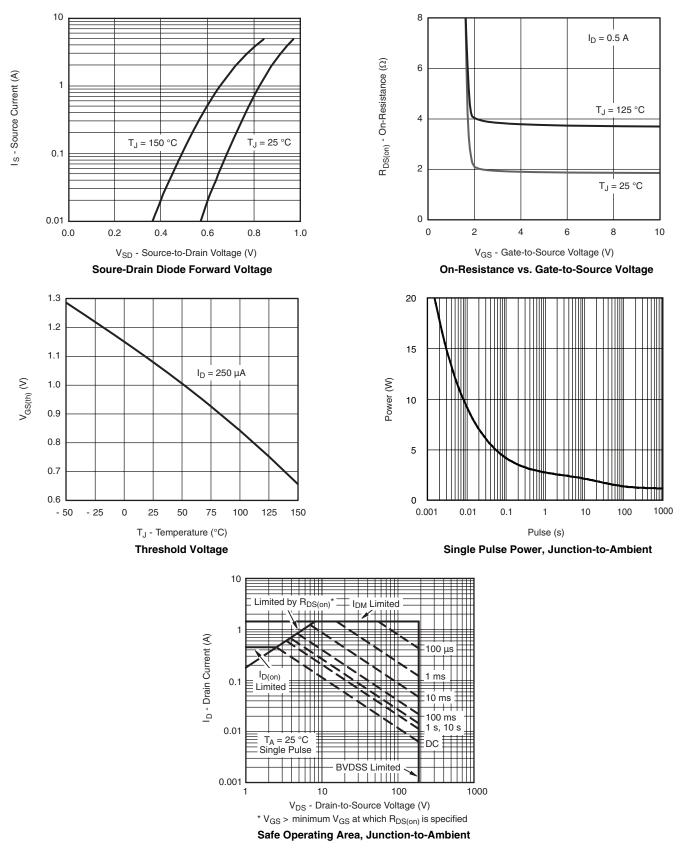


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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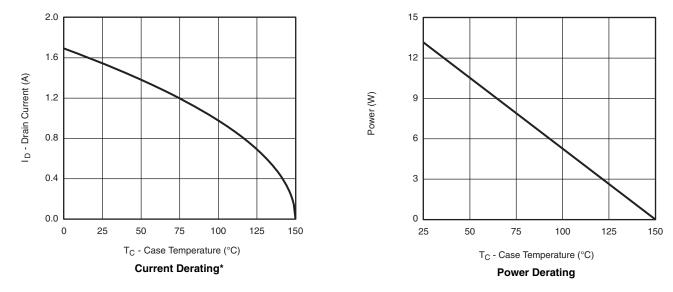
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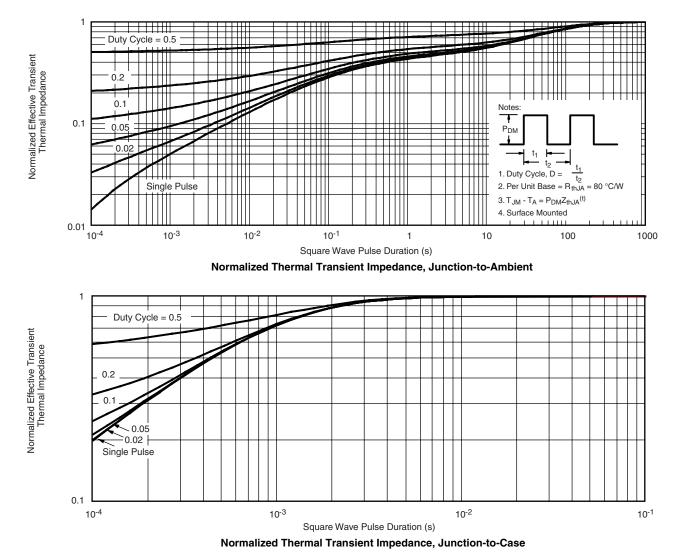


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?68832.



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